

**Notice of References Cited**

Application/Control No.

10/589,869

Applicant(s)/Patent Under

Reexamination

SLAGHEK ET AL.

Examiner

ANTHONY J. CALANDRA

Art Unit

1791

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,120,556	09-2000	Nishino et al.	8/111
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.